

AGH UNIVERSITY OF SCIENCE AND TECHNOLOGY



SALT Chip Testing

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Ideas and open questions

- Who is responsible for testing?
- Difference between prototype and volume production tests
- Wafer screening system \rightarrow time per ASIC
- Flow of tests
- Power consumption measurement
- FE&ADC tests \rightarrow gain, offset, noise performace
- DACs characteristics
- Digital blocks tests \rightarrow full functionality
- Flow of data → yield analysis